

# FDS6990S

# Dual 30V N-Channel PowerTrench<sup>o</sup> SyncFET<sup>™</sup>

### **General Description**

The FDS6990S is designed to replace a dual SO-8 MOSFET and two Schottky diodes in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{DS(ON)}$  and low gate charge. Each MOSFET includes integrated Schottky diodes using Fairchild's monolithic SyncFET technology. The performance of the FDS6990S as the low-side switch in a synchronous rectifier is similar to the performance of the FDS6990A in parallel with a Schottky diode.

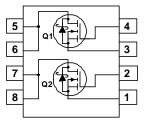
### Applications

- DC/DC converter
- Motor drives

# SO-8 Pin 1 Pin 1

# Features

- 7.5A, 30 V.  $R_{DS(ON)} = 22 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 30 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Includes SyncFET Schottky diode
- Low gate charge (11 nC typical)
- + High performance trench technology for extremely low  $$R_{\text{DS}(\text{ON})}$$
- High power and current handling capability



## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage			30	V	
V <sub>GSS</sub>	Gate-Source Voltage			±20	V	
I <sub>D</sub>	Drain Current – Continuous (Note 1a)			7.5	A	
		– Pulsed		20		
P <sub>D</sub>	Power Dissipation for Dual Operation			2	W	
	Power Dissipation for Single Operation (Note 1a)			1.6		
			(Note 1b)	1		
			(Note 1c)	0.9		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C	
Therma	I Charac	teristics				
R <sub>eja</sub>	Thermal Re	sistance, Junction-to-Aml	bient (Note 1a)	78	°C/W	
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case (Note 1)			40 °C		
Packag	e Markin	g and Ordering	Information			
Device Marking		Device	Reel Size	Tape width	Quantity	
FDS6990S		FDS6990S	13"	12mm	2500 units	

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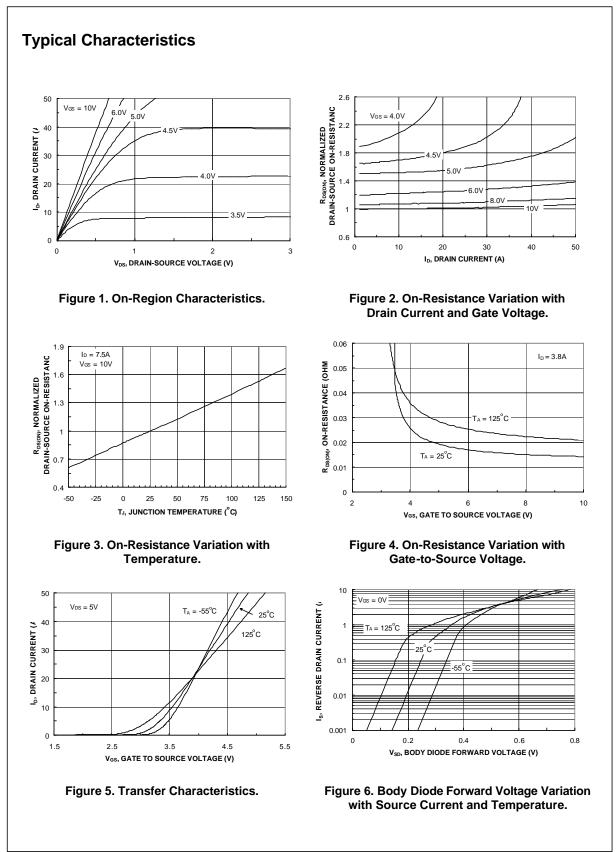
FDS6990S Rev B(W)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		1	I	I	
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 1 mA$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_{D}$ = 1 mA, Referenced to 25°C		23		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			500	μΑ
GSSF	Gate-Body Leakage, Forward	$V_{\text{GS}} = 20 \text{ V}, \qquad V_{\text{DS}} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V} \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	1	2.2	3	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 1$ mA, Referenced to 25°C		-6		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{array}{c} V_{GS} = 10 \ V, \ I_D = 7.5 \ A \\ V_{GS} = 10 \ V, \ I_D = 7.5 \ A, \ T_J = 125^\circ C \\ V_{GS} = 4.5 \ V, \ I_D = 6.5 \ A \end{array} $		17.5 27 24	22 35 30	mΩ
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	20			Α
<b>J</b> FS	Forward Transconductance	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 10 \text{ A}$		22		S
Dvnamio	c Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V$ , $V_{GS} = 0 V$ ,		1233		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0  MHz		344		pF
Crss	Reverse Transfer Capacitance			106		pF
			l			
d(on)	Turn-On Delay Time	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$		8	16	ns
-a(on) -	Turn–On Rise Time	$V_{GS} = 10 V$ , $R_{GEN} = 6 \Omega$		5	10	ns
d(off)	Turn-Off Delay Time			25	40	ns
-d(01) -	Turn–Off Fall Time	-		11	20	ns
יי ק	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_D = 10 \text{ A},$		11	16	nC
g ⊋ <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$		5		nC
Q <sub>qd</sub>	Gate-Drain Charge	-		4		nC
•		nd Meximum Petinge				
	ource Diode Characteristics a Maximum Continuous Drain–Source E	•			2.9	A
s V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 2.9 \text{ A}  (\text{Note 2})$		0.5	0.7	V
rr	Diode Reverse Recovery Time	I <sub>F</sub> = 10A		17		nS
Qrr	Diode Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$ (Note 3)		12.5		nC
the drain pins	m of the junction-to-case and case-to-ambient the R <sub>BJC</sub> is guaranteed by design while R <sub>BCA</sub> is det		ce is define	d as the so	older mount	ting surface

Scale 1 : 1 on letter size paper

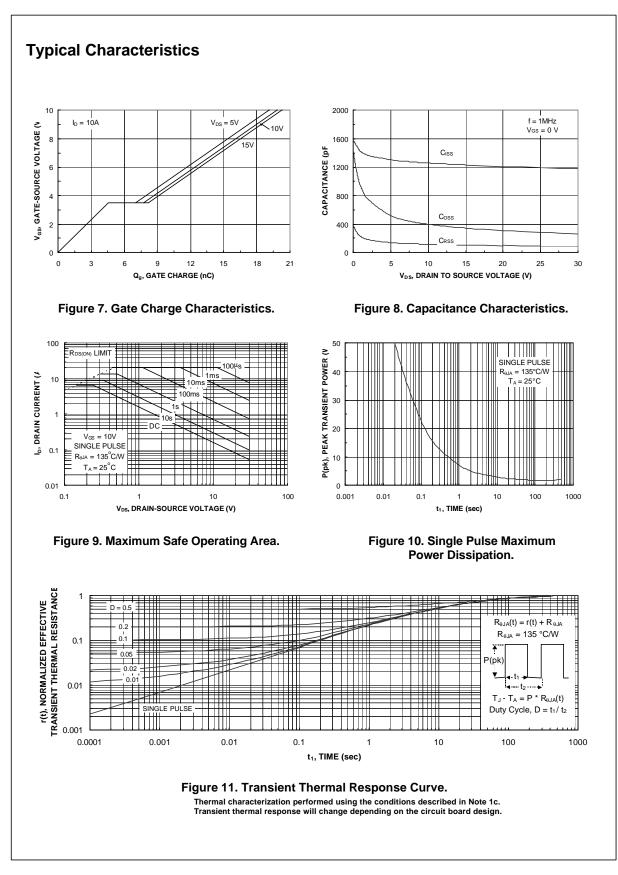
 $\label{eq:2.1} \begin{array}{l} \mbox{2.1 Pulse Test: Pulse Width < 300 $\mu$s, Duty Cycle < 2.0\% $\end{tabular} \end{array}$ 

FDS6990S



FDS6990S Rev B (W)

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FDS6990S Rev B (W)

# Typical Characteristics (continued)

# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6990S.

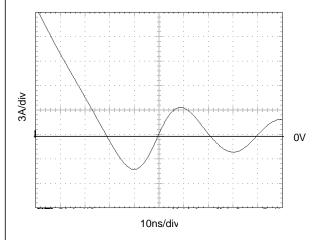
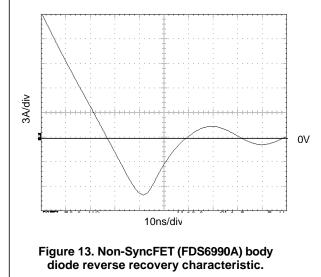


Figure 12. FDS6990S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6990A).



Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

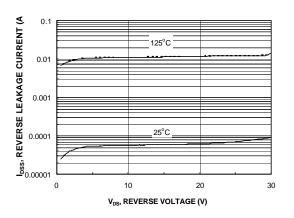
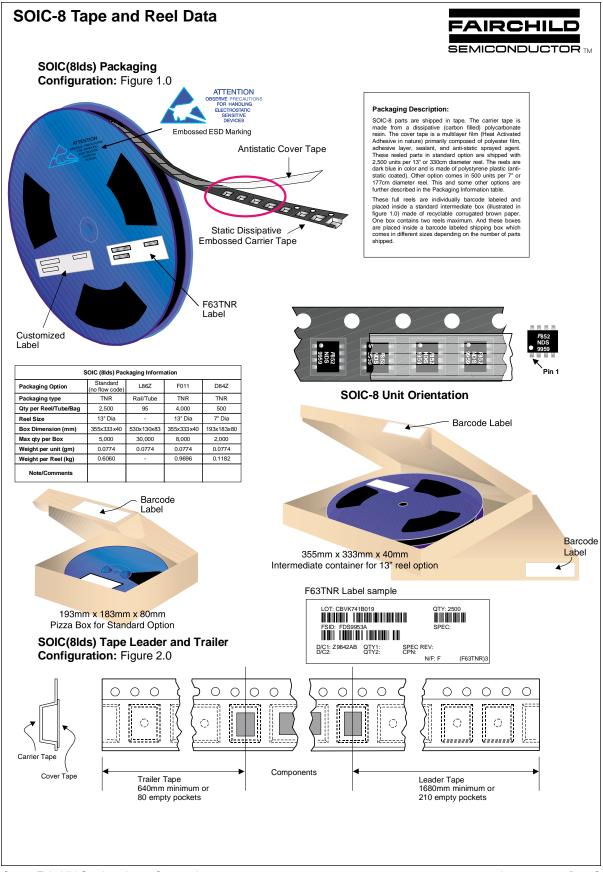


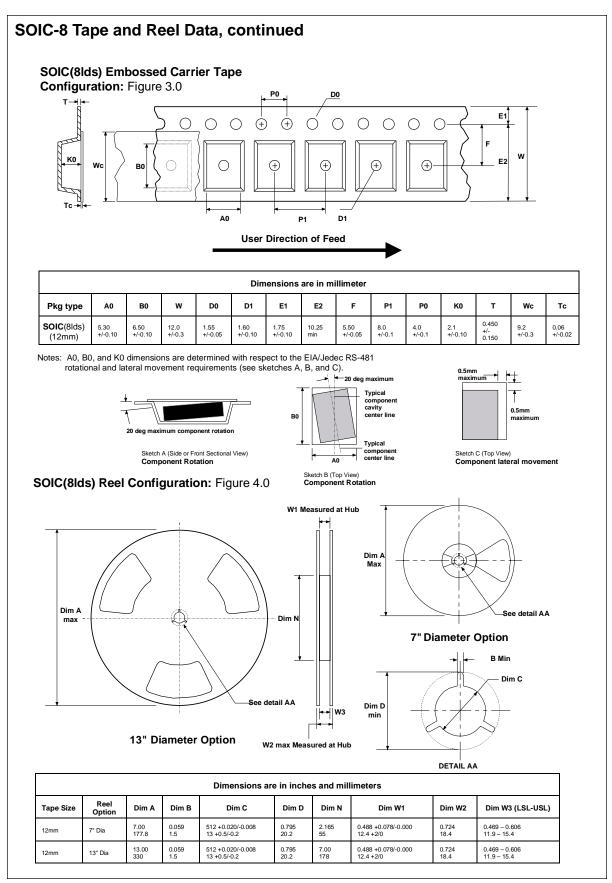
Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

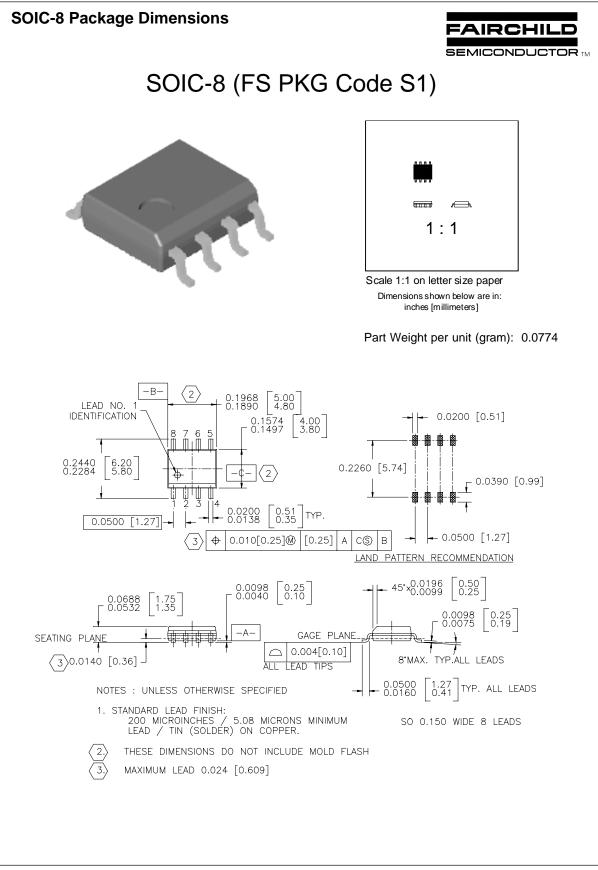
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